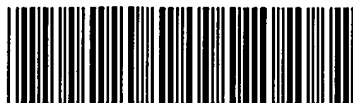


**Search Notes**

Application/Control No.

10/509,433

Examiner

David Vu

Applicant(s)/Patent under  
Reexamination

CHON ET AL

Art Unit

2821

**SEARCHED**

Class	Subclass	Date	Examiner
315	82	8/20/2006	DV
315	156	8/20/2006	DV
315	159	8/20/2006	DV
307	10.8	8/20/2006	DV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
interference search(see search history printout)		8/20/2006	DV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST(see search history printout)	8/20/2006	DV